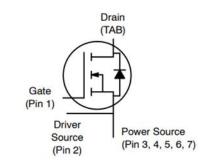


# ES40N120HAA SiC MOSFET

V<sub>DS</sub> = 1200 V I<sub>D</sub> (T<sub>C</sub>=25°C) = 67A R<sub>DS(on).typ</sub> = 35 mΩ@ V<sub>GS</sub>=18 V





Marking

ES40N120HAA

TO-263-7

**Package Parameters** 

Part Number

ES40N120HAA

# Features

- Wide bandgap SiC MOSFET technology
- Low On-Resistance with High Blocking Voltage
- Low Capacitances with High-Speed switching
- Low reverse recovery(Qrr)
- Halogen free, RoHs compliant

#### **Benefits**

- Reduce switching losses
- Increased system Switching Frequency
- Increased power density
- Reduction of heat sink requirements

## Applications

- Switch mode power supplies
- Renewable energy
- Motor drives
- High voltage DC/DC converters

## **Package Pin Definitions**

- Pin1- Gate
- Pin2- Driver Source
- Pin3, 4, 5, 6, 7- Power Source





Package

TO-263-7



# Maximum Ratings (Tc=25 $^{\circ}\!\!\mathrm{C}$ unless otherwise specified)

Symbol	Parameter	Test conditions	Value	Unit	Note
V <sub>DSmax</sub>	Drain-Source Voltage	V <sub>GS</sub> = 0V, <i>I</i> <sub>D</sub> = 100μA	1200	V	
V <sub>GSmax</sub>	Gate-Source voltage	AC (f > 1 Hz)	-10/+25	V	
V <sub>GSop</sub>	Recommend Gate-Source Voltage	Static	-4/+18	V	
	Continuous Drain current	V <sub>GS</sub> = 18V, T <sub>C</sub> = 25°C	67	٨	<b>Fig. 14</b>
Ι <sub>D</sub>		V <sub>GS</sub> = 18V, T <sub>C</sub> = 100°C	47	A	Fig. 14
I <sub>D,pulse</sub>	Pulsed Drain Current	Pulse with $t_p$ limited by $T_{jmax}$	133	А	
PD	Power Dissipation	$T_{\rm C} = 25^{\circ}{\rm C},  T_{\rm j} = 175^{\circ}{\rm C}$	319	W	Fig. 16
Tj	Operating junction temperature		-55~175	°C	
T <sub>stg</sub>	Storage temperature		-55~175	°C	
	TO-247 mounting torque	M3 Screw	0.7	Nm	

# **Thermal Characteristics**

Symbol	Parameter	Value		Unit	Note	
	Falameter	Min.	Тур.	Max.		NOLE
R <sub>th(jc)</sub>	Thermal resistance from Junction to Case		0.47		K/W	<b>Fig. 45</b>
R <sub>th(ja)</sub>	Thermal resistance from Junction to Ambient		40		K/W	Fig. 15



#### Electrical Characteristics *T*<sub>j</sub>=25°C unless otherwise specified

#### **Static Characteristics**

Cumhal	Devementer	Test conditions Min. Typ. M			11	Note	
Symbol	Parameter			Тур.	Max.	Unit	Note
$V_{(BR)DSS}$	Drain-Source Breakdown voltage	V <sub>GS</sub> = 0V, <i>I</i> <sub>D</sub> = 100μA	1200			V	
Veen	Gate Threshold voltage	$V_{GS} = V_{DS}$ , $I_D = 9.5 \text{mA}$		2.9		v	Fig. 9
V <sub>GS(th)</sub>	Gale miesnoù volage	$V_{GS}$ = $V_{DS}$ , $I_D$ = 9.5mA, $T_j$ =175°C		2.0			Fig. 9
lgss	Gate-Source Leakage current	$V_{GS} = 18V, V_{DS} = 0V$			250	nA	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ = 1200V, $V_{GS}$ = 0V, $T_{j}$ = 25°C		1	50	μA	
P	Drain-Source On-state	$V_{GS} = 18V, I_D = 40A$ $V_{GS} = 20V, I_D = 40A$		35 32	48	mΩ	Fig. 3, 4,
R <sub>DS(on)</sub>	$V_{GS} = 18V, I_D = 40A, T_j = 1$	$V_{GS} = 18V, I_D = 40A, T_j = 175^{\circ}C$ $V_{GS} = 20V, I_D = 40A, T_j = 175^{\circ}C$		75 70		11122	5
~	Transconductance	V <sub>GS</sub> = 18 <i>V</i> , <i>I</i> <sub>D</sub> = 40A		25		S	
<b>g</b> <sub>fs</sub>		V <sub>GS</sub> = 18 <i>V, I</i> <sub>D</sub> = 40A, <i>T</i> <sub>j</sub> = 175°C		21		3	Fig. 6



#### **Gate Charge Characteristics**

Symbol	Parameter	Test conditions	Value			Unit	Note
			Min.	Тур.	Max.	Unit	Note
Q <sub>GS</sub>	Gate to Source Charge	<i>V<sub>DS</sub></i> = 800V		22.6			
Q <sub>GD</sub>	Gate to Drain Charge	I <sub>D</sub> = 20A V <sub>GS</sub> = -4V/20V		31.2		nC	Fig. 10
Q <sub>G</sub>	Total Gate Charge			103			

# AC Characteristics (*T*<sub>j</sub>=25°C unless otherwise specified)

Symbol	Parameter	Test conditions	Value			Unit	Note
Symbol	Farameter	Test conditions	Min.	Тур.	Max.	Unit	NOLE
Ciss	Input Capacitance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 1000V		2820		pF	
Coss	Output Capacitance	f =1 MHz V <sub>AC</sub> = 25mV		108		pF	Fig. 13
Crss	Reverse Transfer Capacitance			6.6		pF	
R <sub>G(int)</sub>	Internal Gate Resistance	f=1 MHz, V <sub>AC</sub> = 25mV		1		Ω	



# Reverse Diode Characteristics (*T*<sub>j</sub>=25°C unless otherwise specified)

Symbol	Parameter	eter Test conditions		Value			Note
	Farameter Test conditions	Test conditions	Min.	Тур.	Max.	Unit	Note
Ma	Diado Forward Voltago	V <sub>GS</sub> = -4V, I <sub>SD</sub> = 20A		3.9		V	
V <sub>SD</sub>	Diode Forward Voltage	$V_{GS} = -4V$ , $I_{SD} = 20A$ , $T_j = 175^{\circ}C$		3.3		V	Fig. 7,8
Is	Continuous Diode Forward Current	V <sub>GS</sub> = -4V, T <sub>C</sub> = 25°C		72		A	
I <sub>S, pulse</sub>	Diode pulse Current	$V_{GS}$ = -4V, pulse width t <sub>p</sub> limited by T <sub>jmax</sub>		133		A	



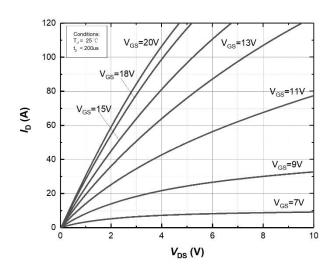


Figure 1. Output characteristics at Tj=25°C

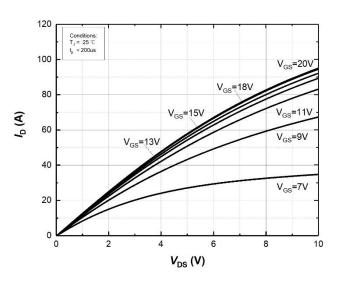


Figure 2. Output characteristics at Tj=175°C

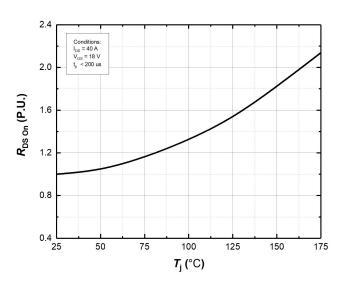
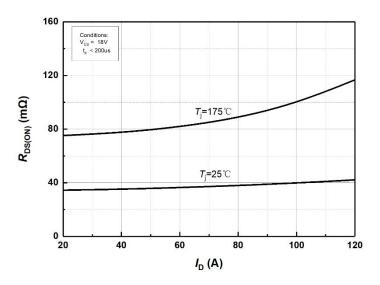


Figure 3. Normalized On-Resistance vs. Temperature







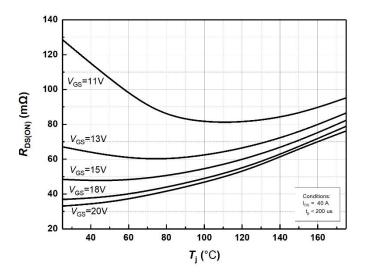
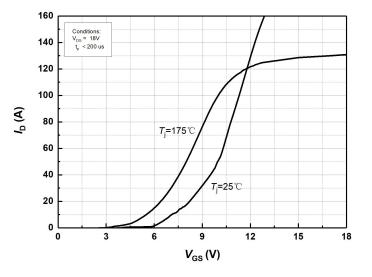
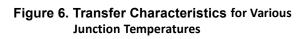


Figure 5. On-Resistance vs. Temperature for Various Gate Voltage





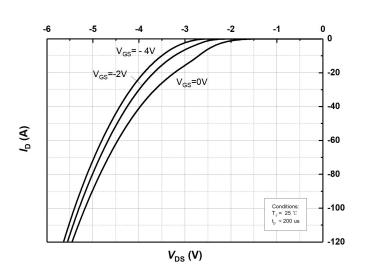
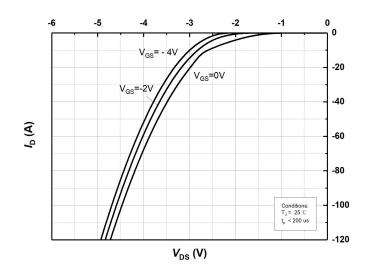
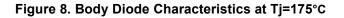


Figure 7. Body Diode Characteristics at Tj=25°C







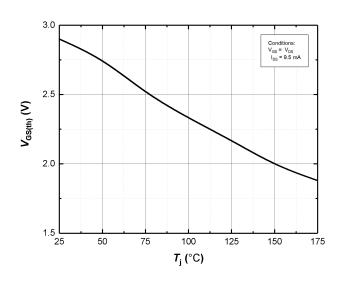


Figure 9. Threshold Voltage vs. Temperature

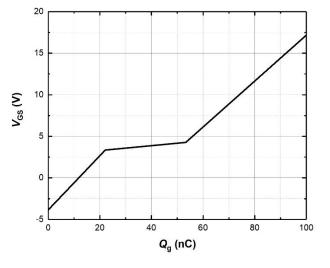


Figure 10 Gate Charge Characteristics

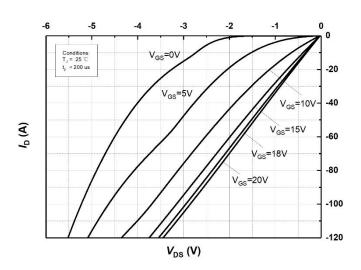
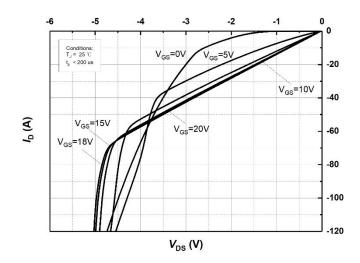


Figure 11. 3rd Quadrant Characteristic at Tj=25°C







ES40N120HAA SiC MOSFET

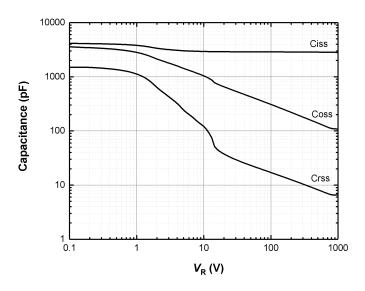


Figure 13. Capacitances vs. Drain-Source Voltage (0 – 1000V)

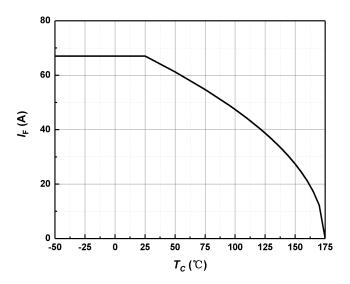
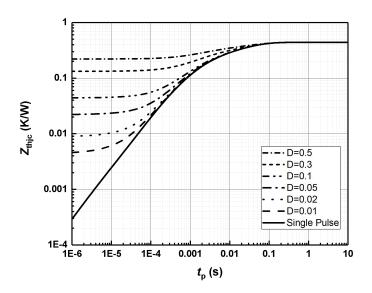
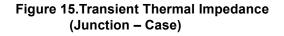


Figure 14. Continuous Drain Current Derating vs Case Temperature





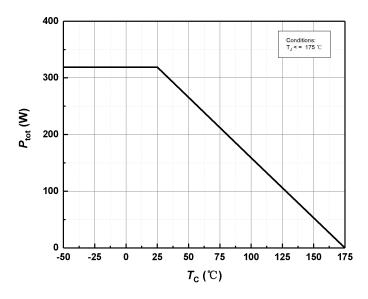
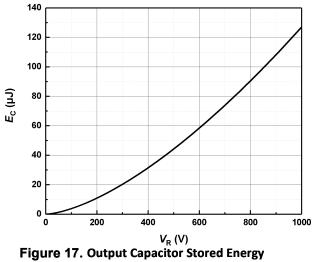


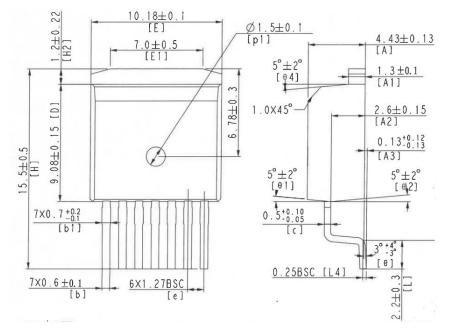
Figure 16. Maximum Power Dissipation Derating vs. Case Temperature

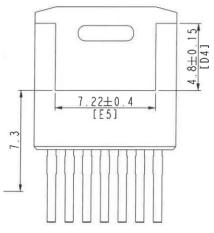






#### Package Dimensions





5°±2 [03	2XR0.5

SYMBOL		MM	
SIMBOL	MIN	NOM	MAX
D	8.93	9.08	9.23
E	10.08	10.18	10.28
A	4.30	4.43	4.56
Η	15.00	15.50	16.00
E1	6.50	7.00	7.50
E2	6.82	7.22	7.62
D4	4.65	4.80	4.95
A1	1.20	1.30	1.40
A2	2.45	2.60	2.75
A3	0.00	0.13	0.25
с	0.45	0.50	0.60
L	2.00	2.20	2.50
b	0.50	0.60	0.70
b1	0.60	0.70	0.90
е		1.27BSC	
E5	6.82	7.22	7.62
L4		0.258BSC	
ΦP1	1.40	1.50	1.60
θ	0.00	3°	7°
θ1	3°	5°	7°
θ2	3°	5°	7°
θ3	3°	5°	7°
θ4	3°	5°	7°
H2	0.98	1.20	1.42



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